MICRO-720	Techniques for Handling Noise and Variability in Analog Circuits				
	Kayal Maher				
Cursus		Sem.	Туре	Language of	English
Microsystems ar	nd Microelectronics		Obl.	teaching	English
				Credits	2
				Session	
				Exam	Written
				Workload	60h
				Hours	33
				Courses	33
				Number of	

Frequency

Every year

Remark

January 22 to 26, 2018

Summary

Fundamentals of Noise in Electronic Devices, Random Mismatch Origins, Noise Analysis in Continuous-Time and Sampled-Data Circuits, Analyzing Mismatch and Yield in Analog Circuits, Noise Cancellation Techniques, Noise Sampling in Switched Capacitor Filters, Offset, CMRR and PSRR.

Content

- 1. Fundamentals of Noise in Electronic Devices
- 2. Random Mismatch Origins
- 3. Noise Analysis in Continuous-Time and Sampled-Data Circuits
- 4. Analyzing Mismatch and Yield in Analog Circuits
- 5. Noise Cancellation Techniques
- 6. Noise Sampling in Switched Capacitor Filters
- 7. Offset, CMRR and PSRR.

Note

* Organized by MEAD/EPFL More informations & registration at: http://mead.ch/MEADNEW/techniques-for-handling-noise-and-variability-in-analog-circuits/ Contact: education@mead.ch

Keywords

Analog Circuit, Noise, Electronic Devices, Continuous-Time, Sampled-Data, Switched Capacitor Filter, CMRR and PSRR.

Learning Prerequisites

Required courses Analog circuits design I & II

Resources

Websites



positions

• http://mead.ch/MEAD/techniques-for-handling-noise-and-variability-in-analog-circuits/